Search Notes			

Application/Control No.	Applicant(s)/Patent und Reexamination	ier
10/825,313	CHOU ET AL.	
Examiner	Art Unit	
John Teresinski	2858	

SEARCHED			
Class	Subclass	Date	Examiner
324	662,690	11/29/2005	JΤ
257	415,418	11/29/2005	JT
73	794, 796	11/29/2005	JT

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
East	11/29/2005	JT	
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